

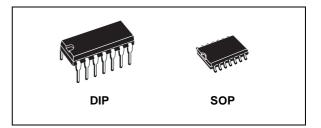
HCF4047B

LOW POWER MONOSTABLE/ASTABLE MULTIVIBRATOR

- LOW POWER CONSUMPTION : SPECIAL CMOS OSCILLATOR CONFIGURATION
- MONOSTABLE (one shot) OR ASTABLE (free-running) OPERATION
- TRUE AND COMPLEMENTED BUFFERED OUTPUTS
- ONLY ONE EXTERNAL R AND C REQUIRED
- BUFFERED INPUTS .
- QUIESCENT CURRENT SPECIFIED UP TO 20V
- STANDARDIZED, SYMMETRICAL OUTPUT CHARACTERISTICS
- 5V, 10V AND 15V PARAMETRIC RATINGS
- INPUT LEAKAGE CURRENT $I_{I} = 100nA (MAX) AT V_{DD} = 18V T_{A} = 25^{\circ}C$
- 100% TESTED FOR QUIESCENT CURRENT
- MEETS ALL REQUIREMENTS OF JEDEC JESD13B " STANDARD SPECIFICATIONS FOR DESCRIPTION OF B SERIES CMOS DEVICES"

DESCRIPTION

The HCF4047B is a monolithic integrated circuit fabricated in Metal Oxide Semiconductor technology available in DIP and SOP packages. The HCF4047B consist of a gatable astable multivibrator with logic techniques incorporated to



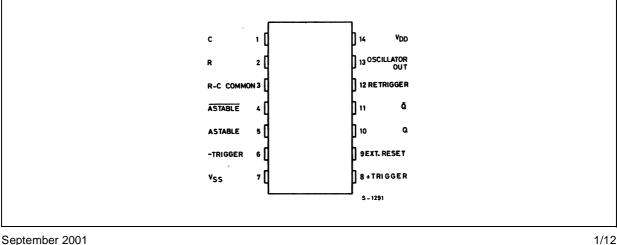
ORDER CODES

PACKAGE	TUBE	T & R
DIP	HCF4047BEY	
SOP	HCF4047BM1	HCF4047M013TR

permit positive or negative edge-triggered monostable multivibrator action with retriggering and external counting options. Inputs include +TRIGGER -TRIGGER, ASTABLE, ASTABLE, RETRIGGER, and EXTERNAL RESET. Buffered outputs are Q, \overline{Q} and OSCILLATOR. In all modes of operation, an external capacitor must be connected between C-Timing and RC-Common terminals, and an external resistor must be connected between **R**-Timina the and RC-Common terminals.

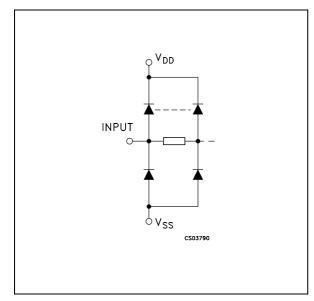
For operating modes see functional terminal connections and application notes.

PIN CONNECTION



HCF4047B

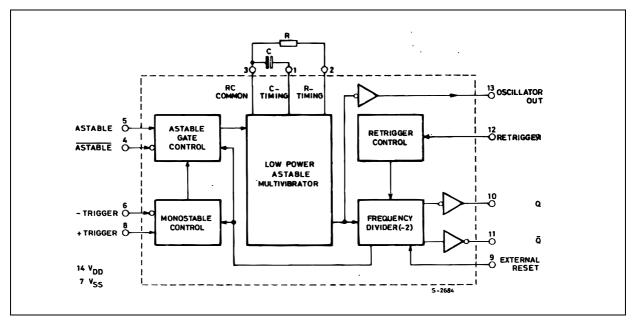
INPUT EQUIVALENT CIRCUIT



PIN DESCRIPTION

PIN No	SYMBOL	NAME AND FUNCTION
1	С	External Capacitor
2	R	External Resistor
3	RC COM- MON	External Connection to (1) and (2)
4	ASTABLE	Complement Astable Pulse
5	ASTABLE	True Astable Pulse
6	-TRIGGER	Negative Trigger Pulse
8	+TRIGGER	Positive Trigger Pulse
9	EXT. RESET	External Reset
12	RETRIG- GER	Retrigger Mode Pulse
13	OSC. OUT	Oscillator Output
10,11	Q, <u>Q</u>	Q Outputs
7	V _{SS}	Negative Supply Voltage
14	V _{DD}	Positive Supply Voltage

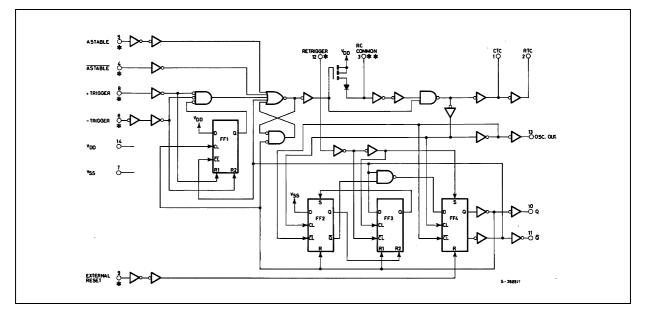
BLOCK DIAGRAM



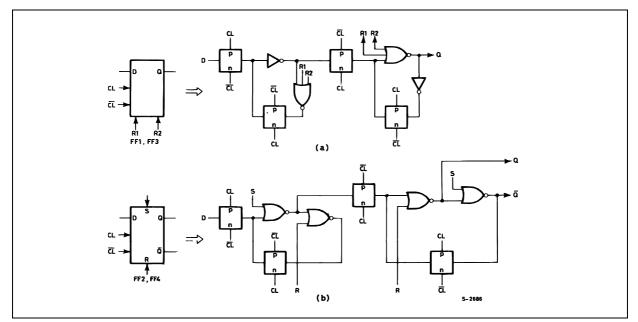
FUNCTIONAL TERMINAL CONNECTIONS

	TERM	INAL CONNEC	TIONS	OUTPUT		
FUNCTION*	to V _{DD}	to V _{SS} Input Pulse to		PULSE FROM	OUTPUT PERIOD OR PULSE WIDTH	
Astable Multivibrator			•			
Free Running	4, 5, 6, 14	7, 8, 9, 12	-	10, 11, 13	t _A (10,11) = 4.40RC	
True Gating	4, 6, 14	7, 8, 9, 12	5	10, 11, 13		
Complement Gating	6, 14	5, 7, 8, 9, 12	4	10, 11, 13	t _A (13) = 2.20RC	
Monostable Multivibrator			•			
Positive - Edge Trigger	4, 14	5, 6, 7, 9, 12	8	10, 11		
Negative - Edge Trigger	4, 8, 14	5, 7, 9, 12	6	10, 11		
Retriggerable	4, 14	5, 6, 7, 9	8, 12	10, 11	t _M (10,11) = 2.48RC	
External Countdown**	14	5, 6, 7, 8, 9, 12	-	10, 11		

LOGIC DIAGRAM



DETAIL FOR FLIP-FLOPS FF1 AND FF3 (a) AND FOR FLIP-FLOPS FF2 AND FF4 (b)



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{DD}	Supply Voltage	-0.5 to +22	V
VI	DC Input Voltage	-0.5 to V _{DD} + 0.5	V
l	DC Input Current	± 10	mA
PD	Power Dissipation per Package	200	mW
	Power Dissipation per Output Transistor	100	mW
T _{op}	Operating Temperature	-55 to +125	°C
T _{stg}	Storage Temperature	-65 to +150	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied. All voltage values are referred to $V_{\mbox{\scriptsize SS}}$ pin voltage.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value	Unit
V _{DD}	Supply Voltage	3 to 20	V
VI	Input Voltage	0 to V _{DD}	V
T _{op}	Operating Temperature	-55 to 125	°C

DC SPECIFICATIONS

			Test Con	dition		Value							
Symbol	Parameter	v	vo	llol	V _{DD}	т	_A = 25°C		-40 to 85°C		-55 to 125°C		Unit
		(v)	(V)	(μΑ)	(V)	Min.	Тур.	Max.	Min.	Max.	Min.	Max.	
١L	Quiescent Current	0/5			5		0.01	1		30		30	
		0/10			10		0.01	2		60		60	
		0/15			15		0.01	4		120		120	μA
		0/20			20		0.02	20		600		600	
V _{OH}	High Level Output	0/5		<1	5	4.95			4.95		4.95		
	Voltage	0/10		<1	10	9.95			9.95		9.95		V
		0/15		<1	15	14.95			14.95		14.95		
V _{OL}	Low Level Output	5/0		<1	5		0.05			0.05		0.05	
Voltage	10/0		<1	10		0.05			0.05		0.05	V	
		15/0		<1	15		0.05			0.05		0.05	
V _{IH}	High Level Input		0.5/4.5	<1	5	3.5			3.5		3.5		
	Voltage		1/9	<1	10	7			7		7		V
			1.5/13.5	<1	15	11			11		11		
VIL	Low Level Input		4.5/0.5	<1	5			1.5		1.5		1.5	
	Voltage		9/1	<1	10			3		3		3	V
			13.5/1.5	<1	15			4		4		4	
I _{OH}	Output Drive	0/5	2.5	<1	5	-1.36	-3.2		-1.15		-1.1		
	Current	0/5	4.6	<1	5	-0.44	-1		-0.36		-0.36		mA
		0/10	9.5	<1	10	-1.1	-2.6		-0.9		-0.9		ШA
		0/15	13.5	<1	15	-3.0	-6.8		-2.4		-2.4		
I _{OL}	Output Sink	0/5	0.4	<1	5	0.44	1		0.36		0.36		
	Current	0/10	0.5	<1	10	1.1	2.6		0.9		0.9		mA
		0/15	1.5	<1	15	3.0	6.8		2.4		2.4		
I	Input Leakage Current	0/18	Any In	put	18		±10 ⁻⁵	±0.1		±1		±1	μΑ
Cl	Input Capacitance		Any In	put			5	7.5					pF

The Noise Margin for both "1" and "0" level is: 1V min. with V_{DD} =5V, 2V min. with V_{DD} =10V, 2.5V min. with V_{DD} =15V

~7

HCF4047B

	_		Test Condition	on	Value (*	*)	Unit
Symbol	Paran	neter	V _{DD} (V)	Min.	Тур.	Max.	
t _{PLH} t _{PHL}	Propagation Delay	Astable, Astable	5		200	400	
	Time	to Osc. Out	10		100	200	
			15		80	160	
		Astable, Astable	5		350	700	
		to Q, Q	10		175	350	
			15		125	250	
		+ o <u>r</u> - Trigger to	5		500	1000	
		Q, \overline{Q}	10		225	450	ns
			15		150	300	
		Retrigger to Q, Q	5		300	600	
			10		150	300	
			15		100	200	
		External Reset	5		250	500	
		to Q, Q	10		100	200	
			15		70	140	
t _{THL} t _{TLH}	Transition Time Osc	c. Out Q, Q	5		100	200	
			10		50	100	ns
			15		40	80	
t _W	Input Pulse Width	+ Trigger	5		200	400	
		- Trigger	10		80	160	
			15		50	100	
		Reset	5		100	200	
			10		50	100	ns
			15		30	60	
		Retrigger	5		300	600	
			10		115	230	
			15		75	150	
t _r , t _f	Input Rise and Fall	Time All Inputs	5				
			10		Unlimite	d	μs
			15				
	Q or \overline{Q} Deviation from	om 50% Duty	5		±0.5	±1	
	Factor		10		±0.5	±1	%
			15		±0.1	±0.5	

DYNAMIC ELECTRICAL CHARACTERISTICS ($T_{amb} = 25^{\circ}C$, $C_{L} = 50pF$, $R_{L} = 200K\Omega$, $t_{r} = t_{f} = 20 \text{ ns}$)

(*) Typical temperature coefficient for all V_{DD} value is 0.3 %/°C.

APPLICATION INFORMATION

1 - CIRCUIT DESCRIPTION

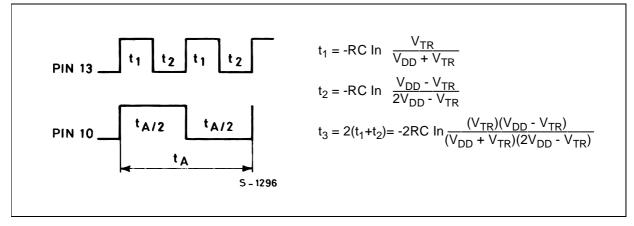
Astable operation is enabled by a high level on the ASTABLE input. The period of the square wave at the Q and Q Outputs in this mode of operation is a function of the external components employed. "True" input pulses on the ASTABLE input or "Complement" pulses on the ASTABLE input allow the circuit to be used as a gatable multivibrator. The OSCILLATOR output period will be half of the Q terminal output in the astable mode. However, a 50% duty cycle is not guaranteed at this output. In the monostable mode, positive-edge triggering is accomplished by application of a leading-edge pulse to the +TRIGGER input and a low level to the -TRIGGER input. For negative-edge triggering, a trailing-edge pulse is applied to the -TRIGGER and a high level is applied to the +TRIGGER. Input pulses may be of any duration relative to the output pulse. The multivibrator can be retriggered (on the leading edge only) by applying a common pulse to both the RETRIGGER and +TRIGGER inputs. In this mode the output pulse remains high as long as the input pulse period is shorter than the period determined by the RC components. An external countdown option can be implemented by

coupling "Q" to an external "N" counter and resetting the counter with the trigger <u>pulse</u>. The counter output pulse is fed back to the ASTABLE input and has a duration equal to N times the period of the multivibrator. A high level on the EXTERNAL RESET input assures no output pulse during an "ON" power condition. This input can also be activated to terminate the output pulse at any time. In the monostable mode, a high-level or power-on reset pulse, must be applied to the EXTERNAL RESET whenever V_{DD} is applied.

2 - ASTABLE MODE

The following analysis presents worst-case variations from unit-to-unit as a function of transfer-voltage (VTR) shift $(33\% - 67\% V_{DD})$ for free-running (astable) operation.

ASTABLE MODE WAVEFORMS



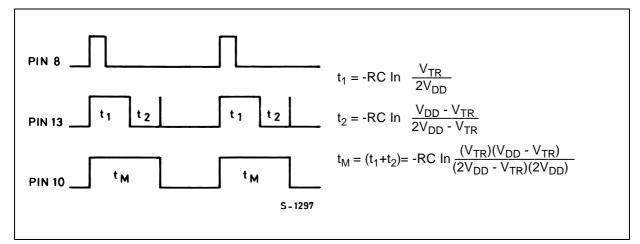
 $\begin{array}{l} Typ: V_{TR} = 0.5 \ V_{DD} \ t_A = 4.40 \ RC \\ Min: V_{TR} = 0.33 \ V_{DD} \ t_A = 4.62 \ RC \\ Max: V_{TR} = 0.67 \ V_{DD} \ t_A = 4.62 \ RC \\ thus \ if \ t_A = 4.40 \ RC \ is \ used, \ the \ maximum \\ variation \ will \ be \ (+ 5.0\%, \ -0.0\%) \\ In \ addition \ to \ variations \ from \ unit-to-unit, \ the \end{array}$

astable period may vary as a function of frequency with respect to V_{DD} and temperature.

3 - MONOSTABLE MODE

The following analysis presents worst-case variations from unit-to-unit as a function of transfer-voltage (V_{TR}) shift (33% - 67% V_{DD}) for one-shot (monostable) operation.

MONOSTABLE WAVEFORMS



Where tM = monostable mode pulse width. Values for tM are as follows :

Typ : V_{TR} = 0.5 V_{DD} t_M = 2.48 RC

Min : $V_{TR} = 0.33 V_{DD} t_M = 2.71 RC$

Max : $V_{TR} = 0.67 V_{DD} t_M = 2.48 \text{ RC}$ Thus if $t_M = 2.48 \text{ RC}$ is used, the maximum variation will be (+ 9.3%, - 0.0%).

Note : In the astable mode, the first positive half cycle has a duration of T_M ; succeeding durations are t_A/2.

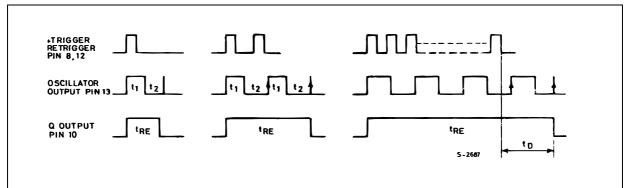
In addition to variations from unit to unit, the monostable pulse width may vary as a function of frequency with respect to V_{DD} and temperature.

4 - RETRIGGER MODE

The HCF4047B can be used in the retrigger mode



to extend the output-pulse duration, or to compare the frequency of an input signal with that of the internal oscillator. In the retrigger mode the input pulse is applied to terminals 8 and 12, and the output is taken from terminal 10 or 11. As shown in fig.A normal monostable action is obtained when one retrigger pulse is applied. Extended pulse duration is obtained when more than one pulse is applied. For two input pulses, $t_{RE} = t_1' + t_1 + 2t_2$. For more than two pulses, t_{RF} (Q OUTPUT) terminates at some variable time $\ensuremath{t_{\mathsf{D}}}$ after the termination of the last retrigger pulse. t_D is variable because t_{RE} (Q OUTPUT) terminates after the second positive edge of the oscillator output appears at flip-flop 4 (see logic diagram).



5 - EXTERNAL COUNTER OPTION

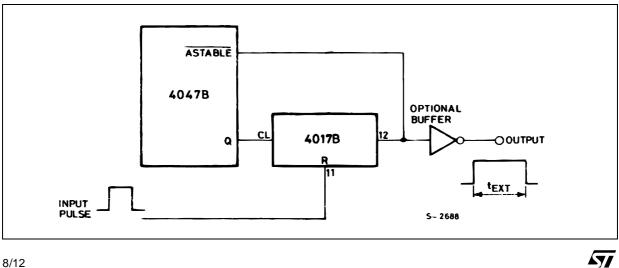
Time $t_{\ensuremath{\mathsf{M}}}$ can be extended by any amount with the use of external counting circuitry. Advantages include digitally controlled pulse duration, small timing capacitors for long time periods, and extremely fast recovery time.

A typical implementation is shown in fig. B. The pulse duration at the output is

text = $(N - 1) (t_A) + (t_M + t_A/2)$

Where text = pulse duration of the circuitry, and N is the number of counts used.





6 - POWER CONSUMPTION

In the standby mode (Monostable or Astable), power dissipation will be a function of leakage current in the circuit, as shown in the static electrical characteristics. For dynamic operation, the power needed to charge the external timing capacitor C is given by the following formula : Astable Mode :

 $P = 2CV^2 f$. (Output at Pin 13) $P = 4CV^2 f$. (Output at Pin 10 and 11)

Monostable Mode : P =
$$\frac{(2.9 \text{CV}^2) \text{ (Duty Cycle)}}{\text{T}}$$

The circuit is designed so that most of the total power is consumed in the external components. In practice, the lower the values of frequency and voltage used, the closer the actual power dissipation will be to the calculated value.

Because the power dissipation does not depend on R, a design for minimum power dissipation would be a small value of C. The value of R would depend on the desired period (within the limitations discussed above).

7 - TIMING-COMPONENT LIMITATIONS

TEST CIRCUIT

The capacitor used in the circuit should be non-polarized and have low leakage (i.e. the parallel resistance of the capacitor should be an order of magnitude greater than the external resistor used). Three is no upper or lower limit for either R or C value to maintain oscillation.

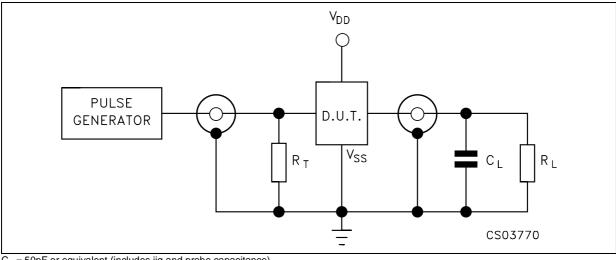
However, in consideration of accuracy, C must be much larger than the inherent stray capacitance in the system (unless this capacitance can be measured and taken into account). R must be much larger than the COS/MOS "ON" resistance in series with it, which typically is hundreds of ohms. In addition, with very large values of R, some short-term instability with respect to time may be noted.

The recommended values for these components to maintain agreement with previously calculated formulas without trimming should be :

 $C \ge 100 pF$, up to any practical value, for astable modes ;

C \geq 1000pF, up to any practical value, for monostable modes.

10KΩ<u><</u> R <u><</u> 1MΩ.

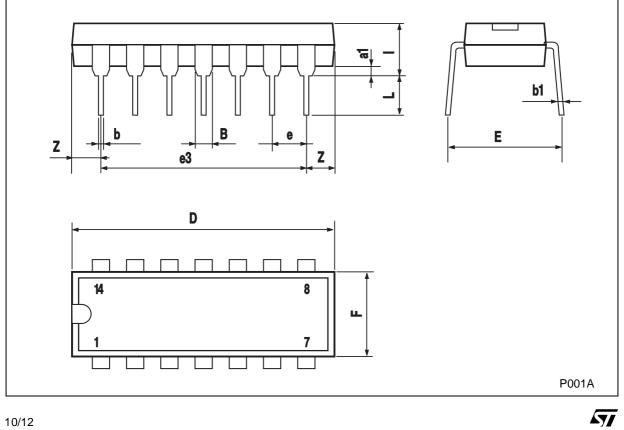


 $C_L = 50 pF$ or equivalent (includes jig and probe capacitance) $R_L = 200 K\Omega$

 $R_T = Z_{OUT}$ of pulse generator (typically 50 Ω)

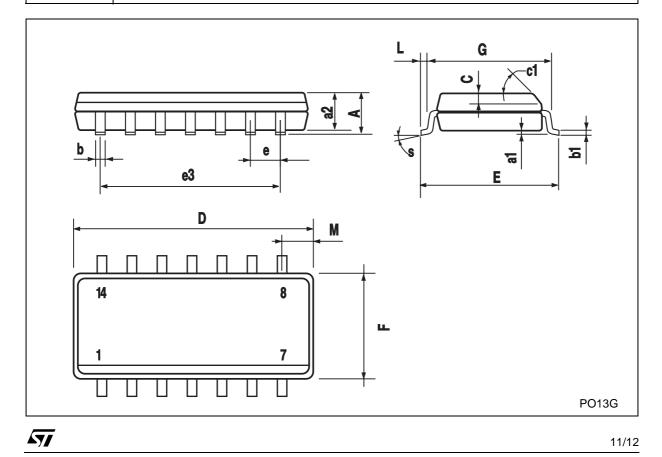
Г

	Plastic DIP-14 MECHANICAL DATA							
DIM.		mm.		inch				
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.		
a1	0.51			0.020				
В	1.39		1.65	0.055		0.065		
b		0.5			0.020			
b1		0.25			0.010			
D			20			0.787		
E		8.5			0.335			
е		2.54			0.100			
e3		15.24			0.600			
F			7.1			0.280		
ļ			5.1			0.201		
L		3.3			0.130			
Z	1.27		2.54	0.050		0.100		



DIM.		mm.		inch				
DIM.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.		
А			1.75			0.068		
a1	0.1		0.2	0.003		0.007		
a2			1.65			0.064		
b	0.35		0.46	0.013		0.018		
b1	0.19		0.25	0.007		0.010		
С		0.5			0.019			
c1		•	45°	(typ.)	•			
D	8.55		8.75	0.336		0.344		
Е	5.8		6.2	0.228		0.244		
е		1.27			0.050			
e3		7.62			0.300			
F	3.8		4.0	0.149		0.157		
G	4.6		5.3	0.181		0.208		
L	0.5		1.27	0.019		0.050		
М			0.68			0.026		





Information furnished is believed to be accurate and reliable. However, STMicroelectronics assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of STMicroelectronics. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. STMicroelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of STMicroelectronics.

© The ST logo is a registered trademark of STMicroelectronics

© 2001 STMicroelectronics - Printed in Italy - All Rights Reserved STMicroelectronics GROUP OF COMPANIES Australia - Brazil - China - Finland - France - Germany - Hong Kong - India - Italy - Japan - Malaysia - Malta - Morocco Singapore - Spain - Sweden - Switzerland - United Kingdom © http://www.st.com

12/12

